


<b>Search Notes</b>  	<b>Application/Control No.</b>  10660683	<b>Applicant(s)/Patent Under Reexamination</b>  EBISAWA, TAKASHI
	<b>Examiner</b>  Patel, Jayesh A	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	273,275,274,271,266,264,263,256,258,266	01/22/07	JP
358	462	06/17/07	JP

SEARCH NOTES		
Search Notes	Date	Examiner
See attached East Search History		
See attached east Search history	03/21/08	JP
Consulted with SPE Matthew bella regarding making a 103.	03/21/08	JP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner